NdGaO₃ (Neodymium Gallate) Substrate

Although it has an orthorhombic crystal structure, the Ga–Ga interatomic distance is approximately 0.386 nm on the (110) and (001) planes, making it widely used as a substrate with a lattice constant intermediate between SrTiO₃ and LaAlO₃.

High-quality crystals can be reliably obtained through the Czochralski (CZ) method using a stoichiometric melt.

[Features]

- Lattice constant intermediate between SrTiO₃ and LaAlO₃ substrates
- High-quality crystals can be stably obtained
- In-house crystal production enables excellent QCD (Quality, Cost, Delivery) performance



FWHM = 0.0049 deg. = 18 arcsec 23.53 23.55 ω (deg.) (004) Rocking curve



[Characteristics]

Crystal system	Orthorhombic		
Crystal structure	Perovskite		
Lattice constant	a = 0.5431 nm b = 0.5499 nm c = 0.7710 nm		
Melting point	1650 °C		
Density	7.56 g/cm ³		
Dielectric constant	20∼25 (27°C,1MHz)		
Thermal expansion	10 × 10 ⁻⁶ /°C		

[Standard Specifications]

Orientation	(100),(001),(110),(011) Tolerance : ±0.5°			
Size	10 × 10 × 0.5mm 15 × 15 × 0.5mm Tolerance (outside dimension) : ±0.1 mm Tolerance (thickness) : ±0.05 mm			
Polishing	One-side / Both-side			
Surface roughness	Ra ≦1.0nm,Rmax ≦5.0nm			
Flatness	$10 \times 10 \times 0.5$ mm: $\leq \lambda$ $15 \times 15 \times 0.5$ mm: $\leq 1.5\lambda$ (λ =632.8nm)			

If you are looking for other specs, please contact us.

NdGaO₃ Model list

Size (mm)	Polishing	Orientation			
		(100)	(001)	(110)	(011)
10x10x0.5mm	One-side	0	0	*	Δ
11	Both-side	Δ	Δ	Δ	Δ
15x15x0.5mm	One-side	Δ	Δ	Δ	Δ
"	Both-side	Δ	Δ	Δ	Δ

★:Planed inventory

O:Standard

△: Made-to-order

Planned inventory: Production is regularly managed to ensure prompt delivery.
(Please note that specifications may change without prior notice.)
We also accept orders for different sizes and off-spec substrates.

Please contact us for details.

Model Number Orientation Flat Orientation Flat C 0.5 C 0.5 Polishing Surface treatment One-side polished type S: One-side N: Normal W: Both-side Orientation Flat NGO -C 1.0 C 0.5 Both-side polished type Orientation Size Offset angle type $10:10 \times 10 \times 0.5 \text{ mm}$ A: (100) $15:15 \times 15 \times 0.5 \text{ mm}$ C: (001) D: (110) Substrate **Orientation Flat** F: (011) Orientation (100)(001)(001)(100)

<Visual check note>

We pass over the following:

(a) Chips within 0.2mm from the circumference of substrates

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(b) Chips on the edge strip under 1/2 size of substrate thickness

(c) Scratches and blemish on the back side of single-side polished substrates

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(110)

(011)

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(001)

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